

# Preliminary Results on Long Range Wakefield Study in Cold LC

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- TESLA main linac layout
- Dipole wakefields
- RMS of sum wake
- Bunch dynamics simulations
- Random detuning and interleaving
- Dipole modes in TTF cavities

# Introduction

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- Study various options for minimal long range wakefield effects in TESLA
  - cavity detuning
    - random detuning
    - interleaving: purposely detuning sets of cavities
  - tolerance on misalignment of cavities
- Tolerances
  - systematic errors in frequency
  - beam dynamics simulations
  - study of RMS and standard deviation of sum wakefield

# TESLA Linac

- Based on TESLA500 design

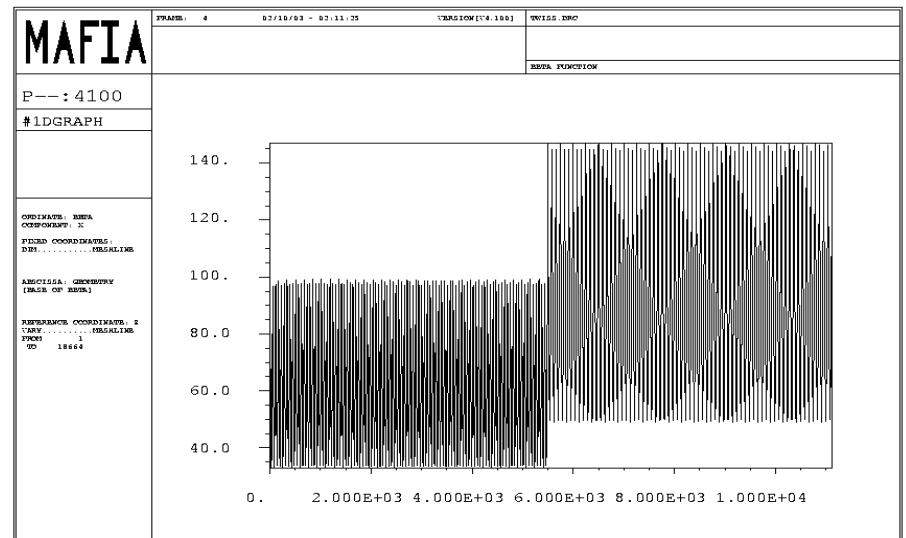
- 12 1m-long cavities (9 cells/cavity) per cryo-module
- ~10,000 cavities per linac
- cavity misalignment 500  $\mu\text{m}$
- phase advance per FODO cell: 60 deg
- 1<sup>st</sup> section: 4 modules / FODO
- 2<sup>nd</sup> section: 6 modules / FODO

- Accelerating mode

- gradient: **25 MV/m**
- $f_0 = 1.3 \text{ GHz}$ ,  
 $Q = 3.e6$ ,  $k_{\text{loss}} = 2. \text{ V/pC}$

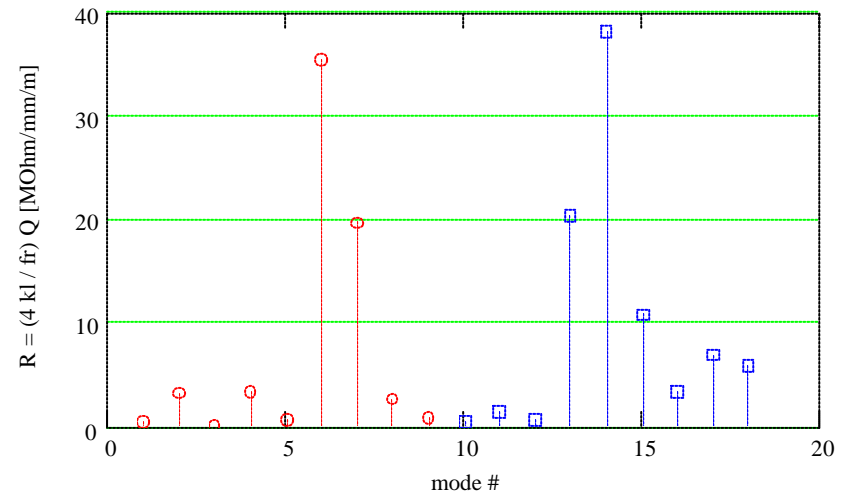
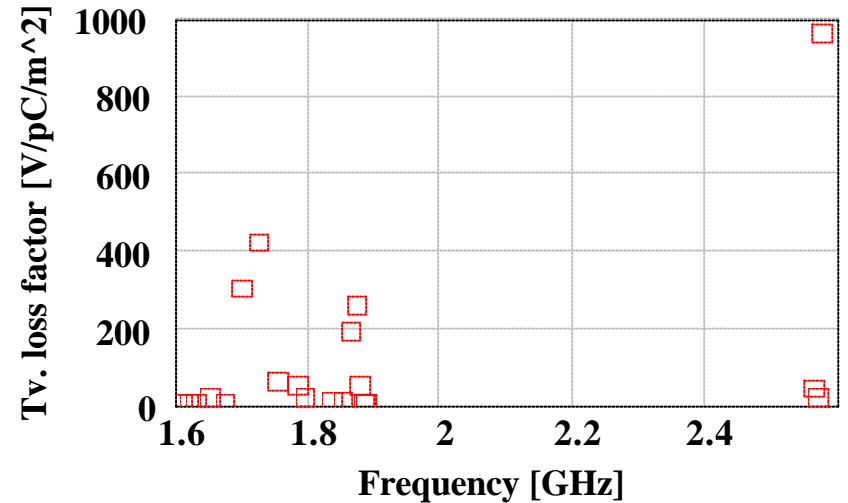
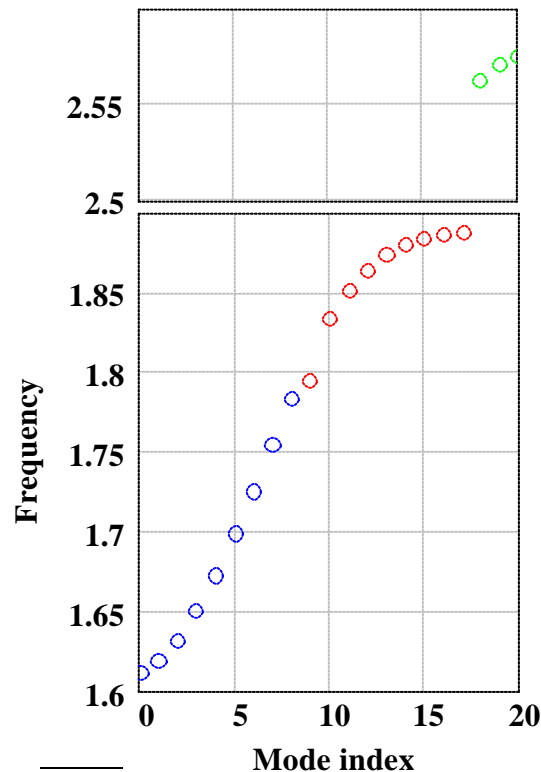
- Bunch train

- 2820 bunches, but use only 5-600 (steady state reached)
- 3.2 nC, 337 ns spacing
- injection energy 5 GeV

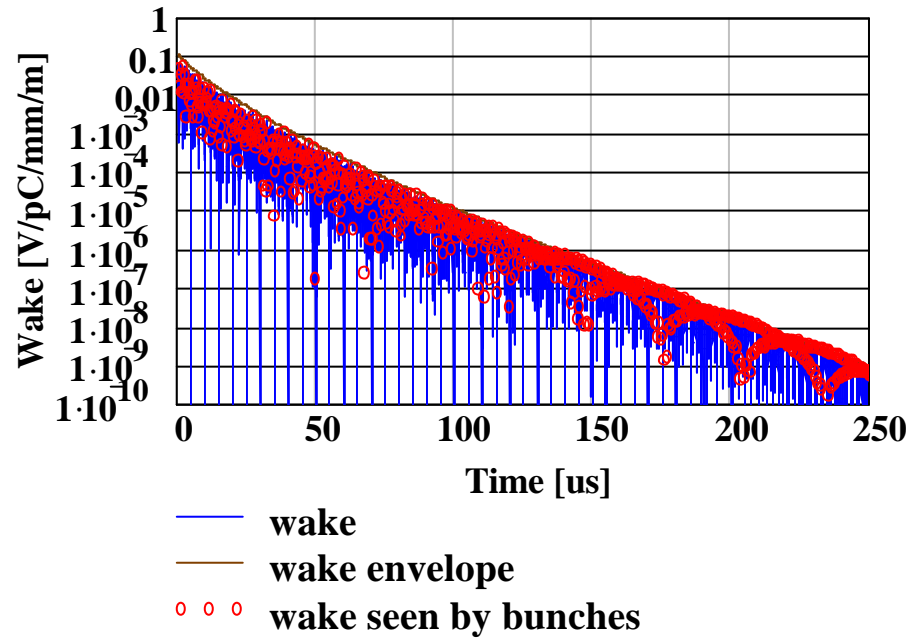


# HOMs in TTF Modules

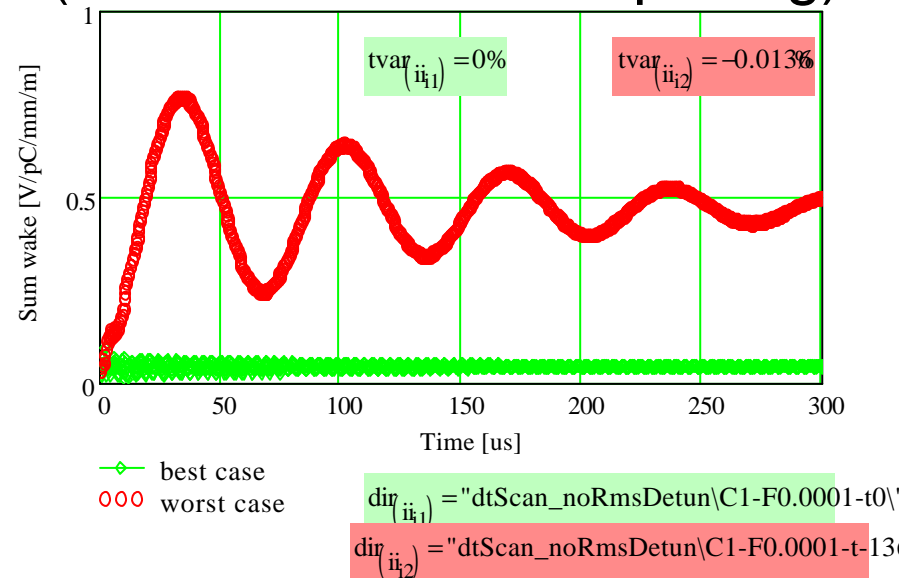
- Consider 14 dipole modes from 1<sup>st</sup>, 2<sup>nd</sup> and 3<sup>rd</sup> dipole passbands, with highest impedance (as measured at TTF1)



# Dipole Wakefield



## Sum wake (for different bunch spacing)



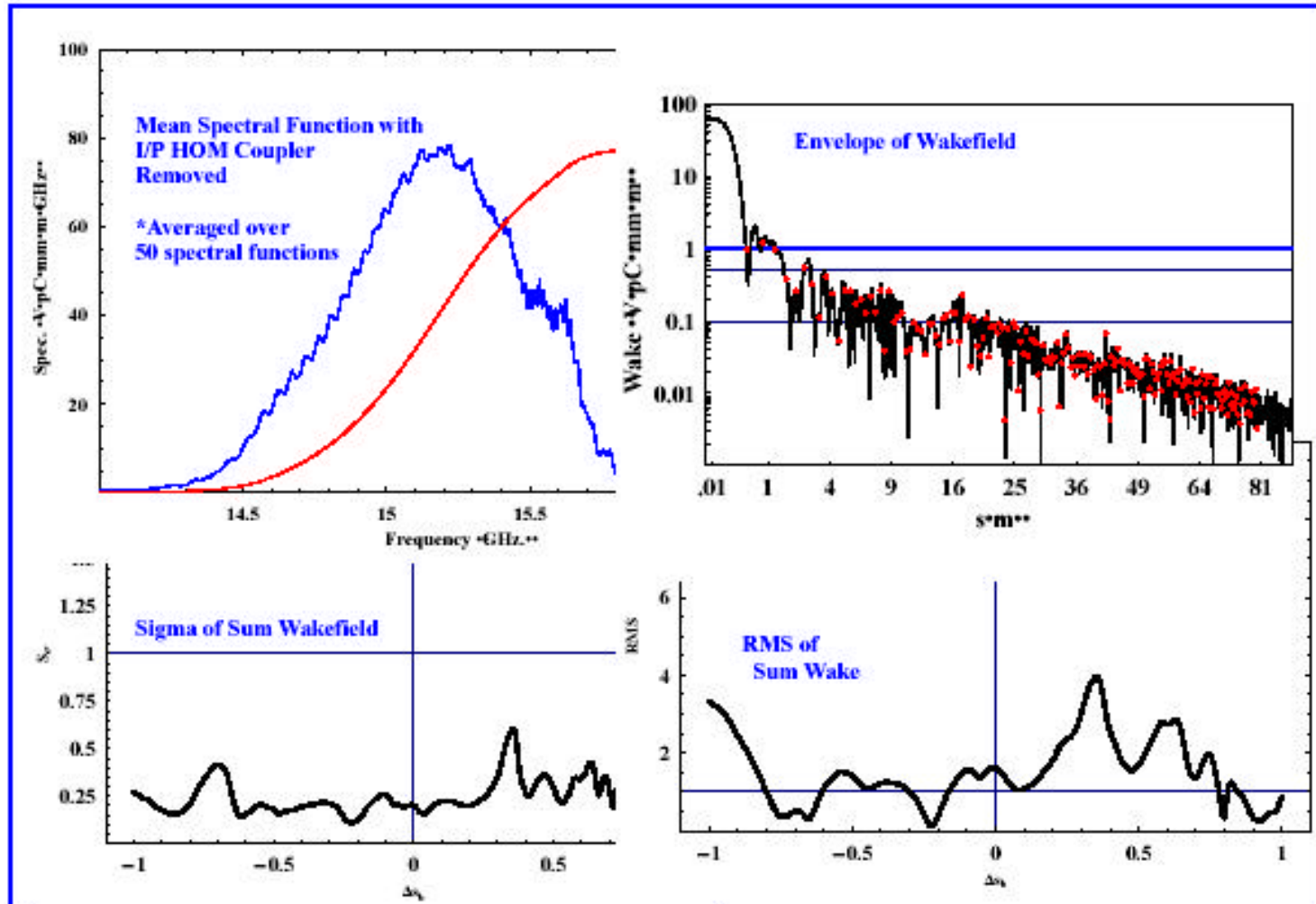
# RMS and Standard Deviation of Sum Wake

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- For NLC

- relatively standard tools to measure WF effects
- 1. the wakefield at the first trailing bunch
- 2. RMS of sum wake → indicator whether BBU will occur
- 3. StDev of sum wake → indicator of alignment tolerances

# Example for one NLC Structure

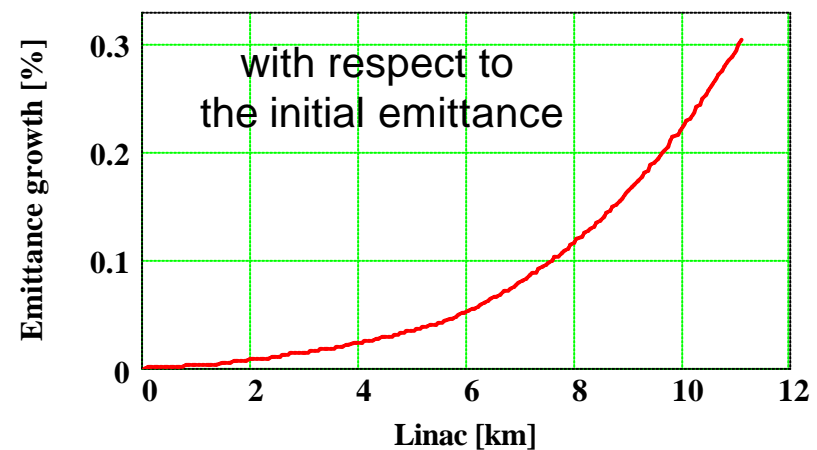
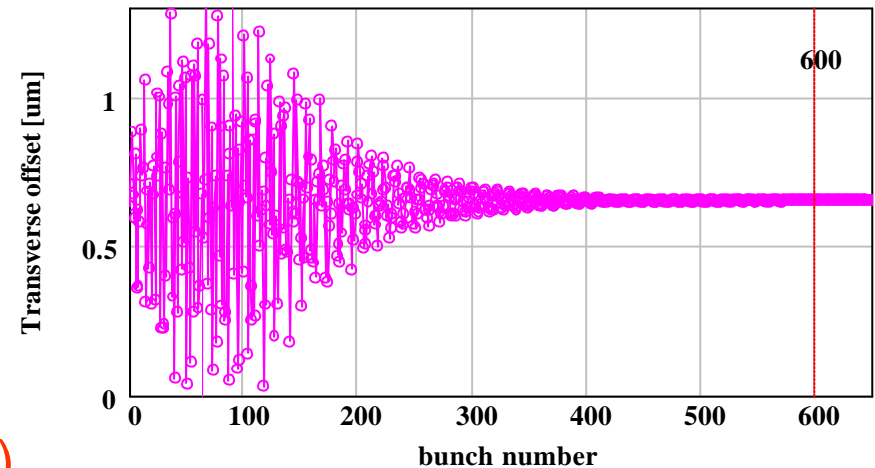
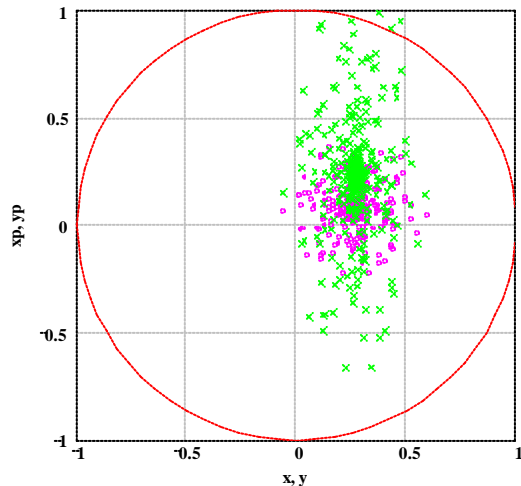


Roger M. Jones (Structures Meeting, SLAC, March 11, 2004)

# Beam Dynamics Simulations with MAFIA-L

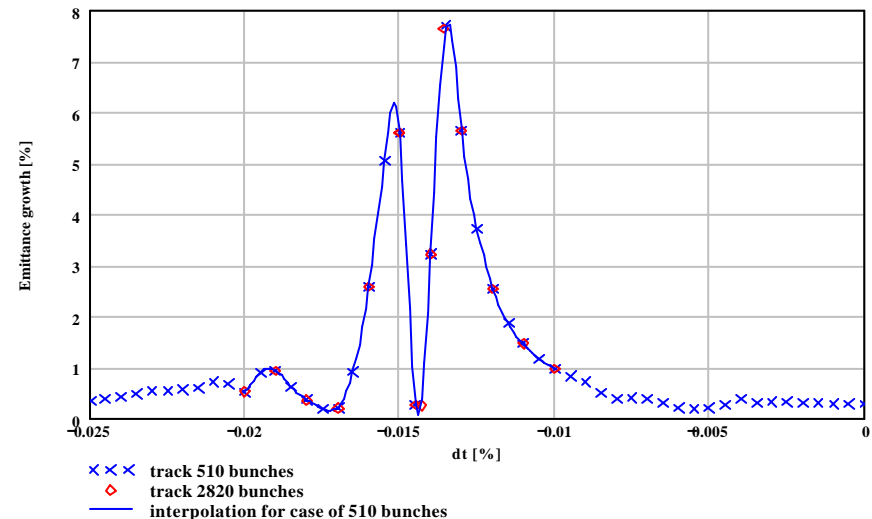
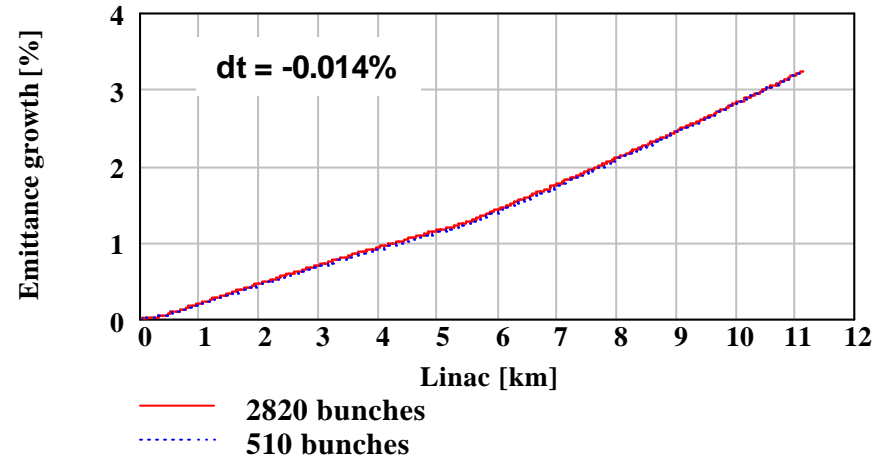
- Assumptions

- No beam loading
- No detuning
- No short range wakes
- no misalignment of cavities
- 4  $\mu\text{m}$  injection offset ( $\sigma \sim 18\mu\text{m}$ )



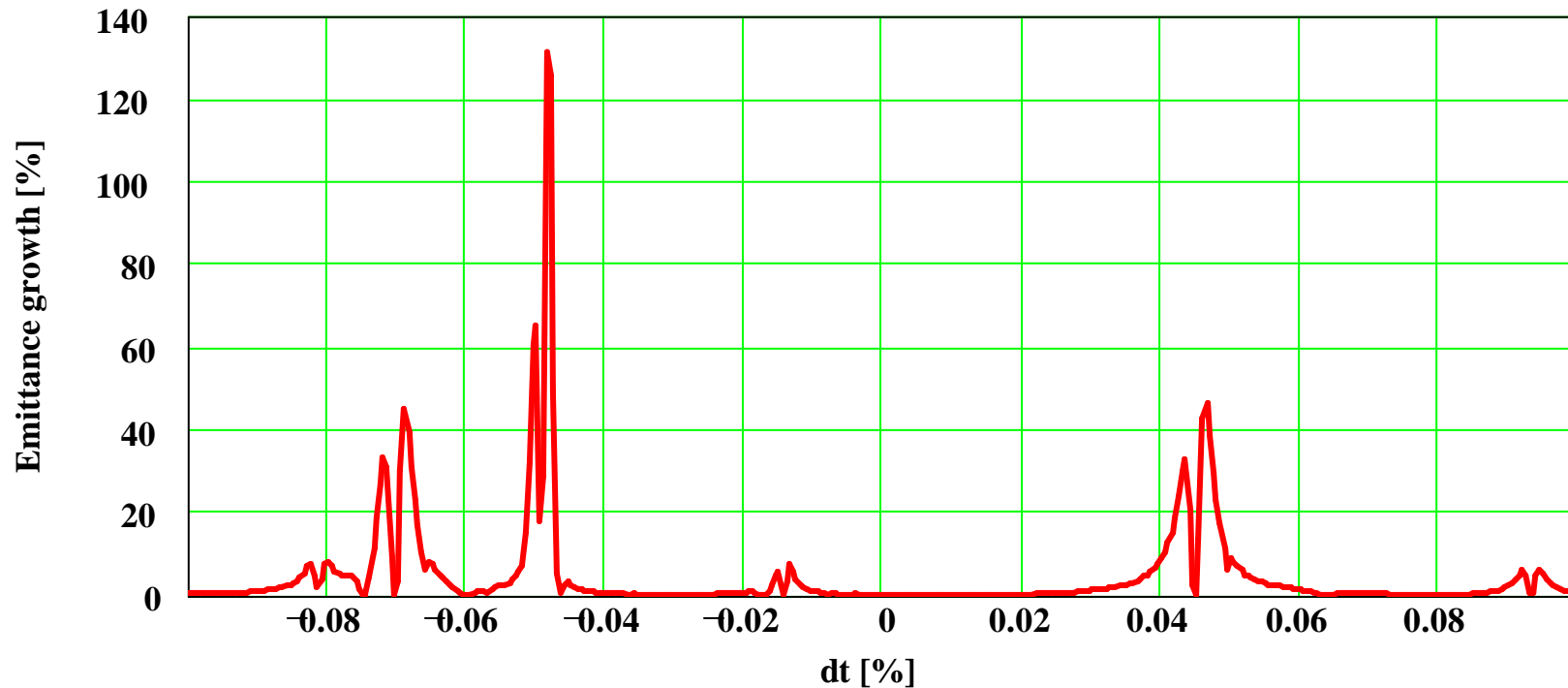
# Simulation with Full and Truncated Bunch Train

- Compare tracking with
  - 510 bunches (then normalize emittance to full train)
  - 2820 bunches
- Simulation
  - no cavity misalignment
  - 4  $\mu\text{m}$  injection offset
- $\Rightarrow$  it is sufficient to track 5-600 bunches down the long linac then normalize to full train



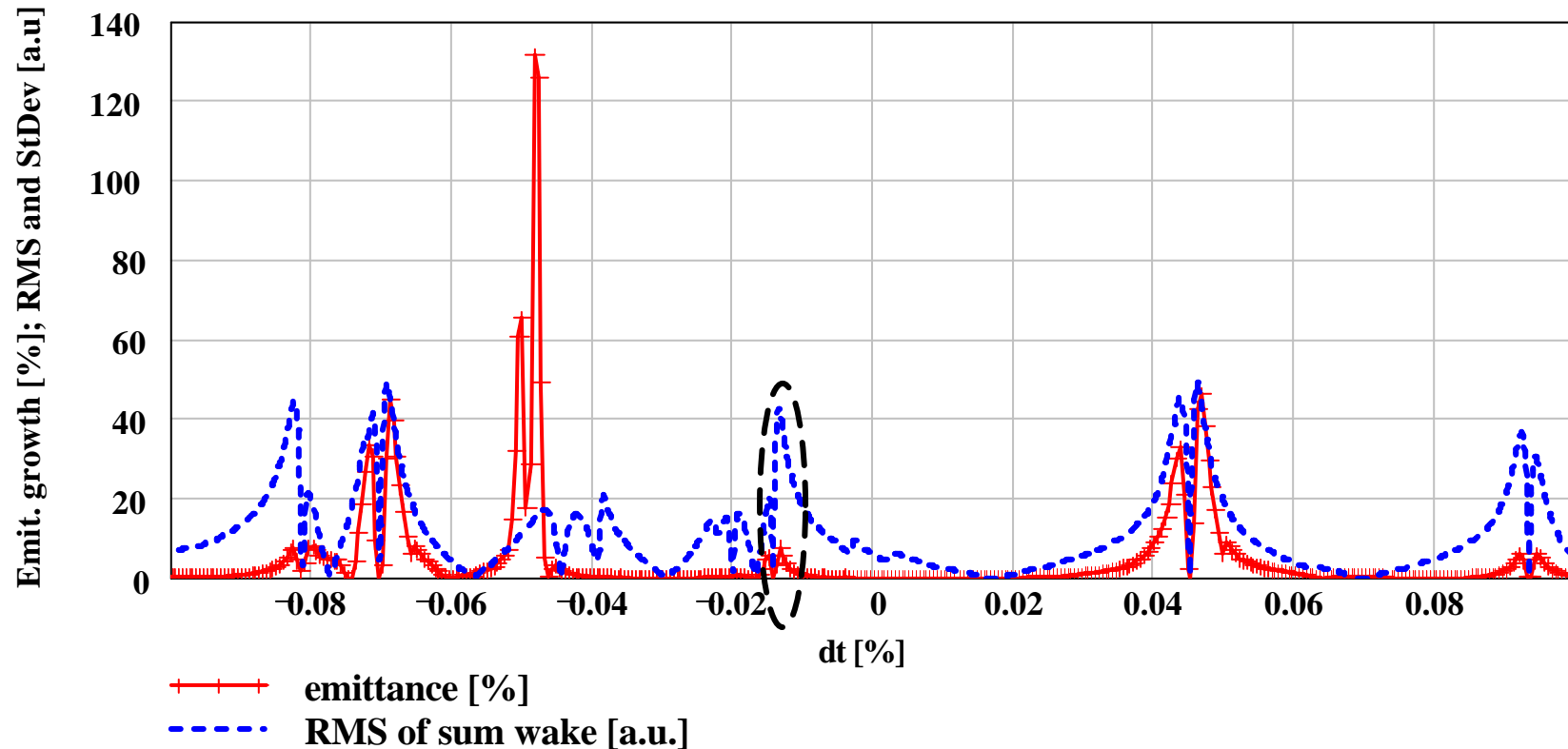
# Emittance Scan

- Simulate systematic error in cavity detuning by varying bunch spacing
  - $t_b = t_{b0} (1 + dt)$
  - no misalignment of cavities
  - 4  $\mu\text{m}$  injection offset



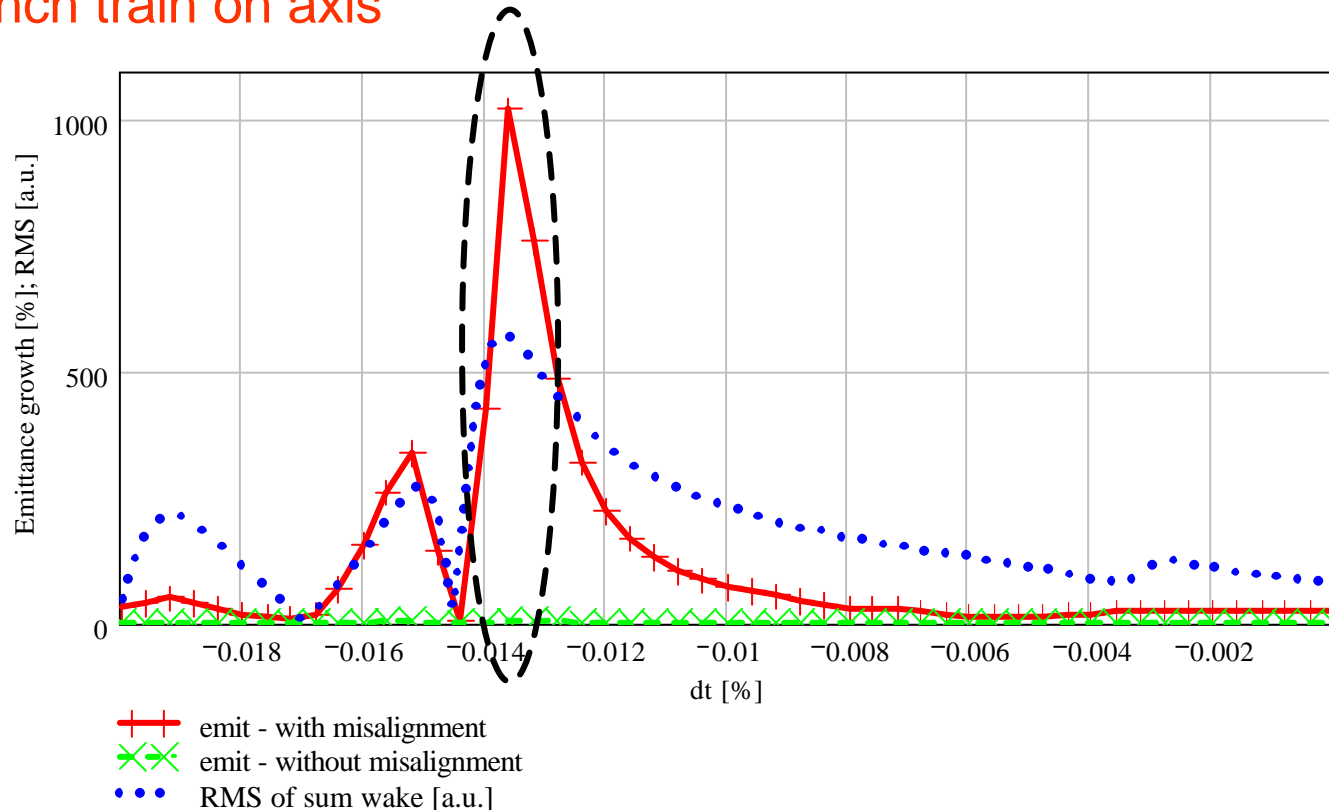
# RMS of Sum Wake

- no misalignment of cavities
- 4  $\mu\text{m}$  injection offset



# Cavity Misalignment

- Misalign cavities: 500  $\mu\text{m}$  rms
- Inject bunch train on axis



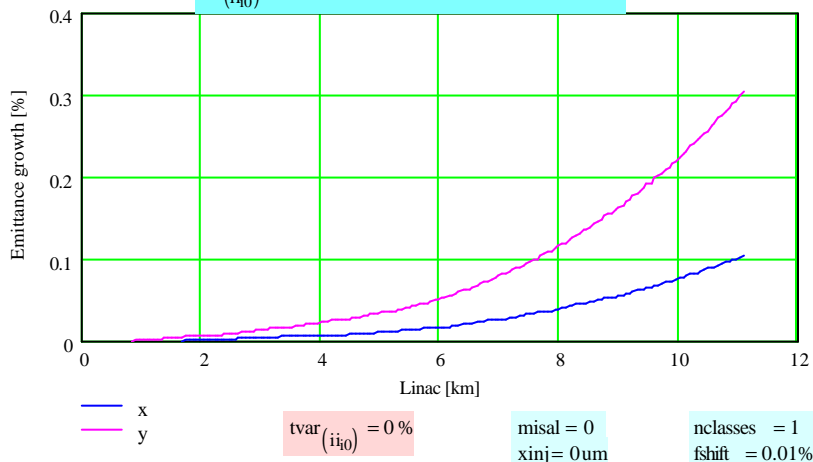
- Even for design bunch spacing:  $\Delta\varepsilon \sim 25\%$
- But detuning of cavities has positive effect

# Emittance Growth

**dt = 0**

no cav. misal.

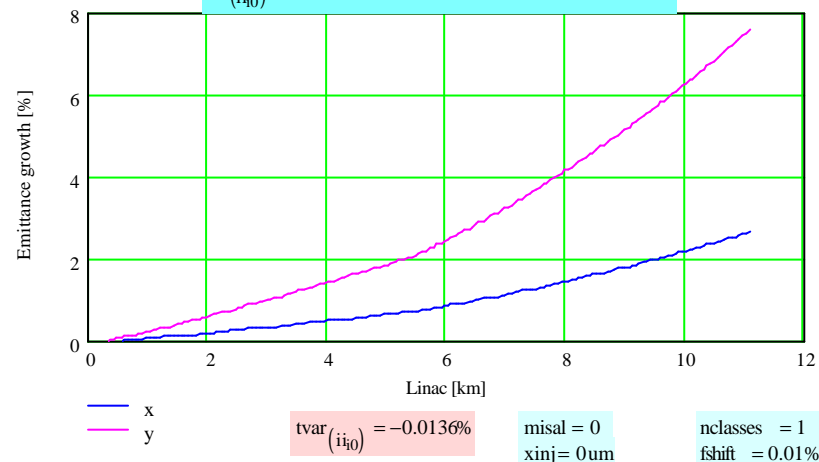
$\text{dir}_{(i_{i_0})} = \text{"dtScan\_noRmsDetun(C1-F0.0001-t0)"}$



**max emittance growth**

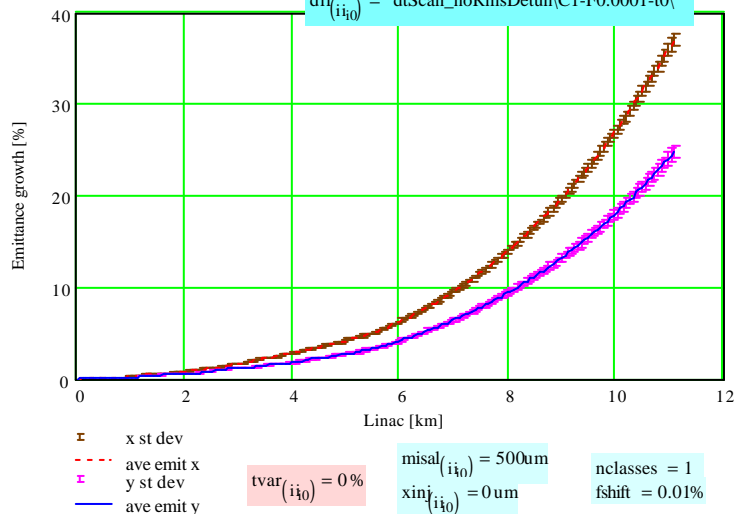
no cav. misal.

$\text{dir}_{(i_{i_0})} = \text{"dtScan\_noRmsDetun(C1-F0.0001-t-13600)"}$



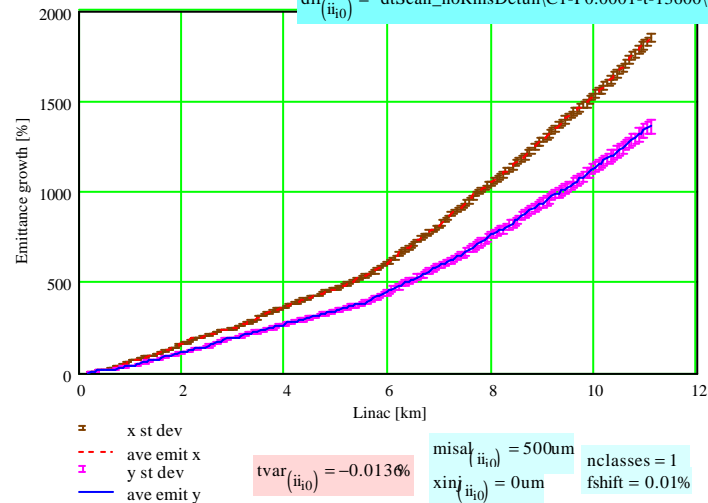
with cav. misal.

$\text{dir}_{(i_{i_0})} = \text{"dtScan\_noRmsDetun(C1-F0.0001-t0)"}$



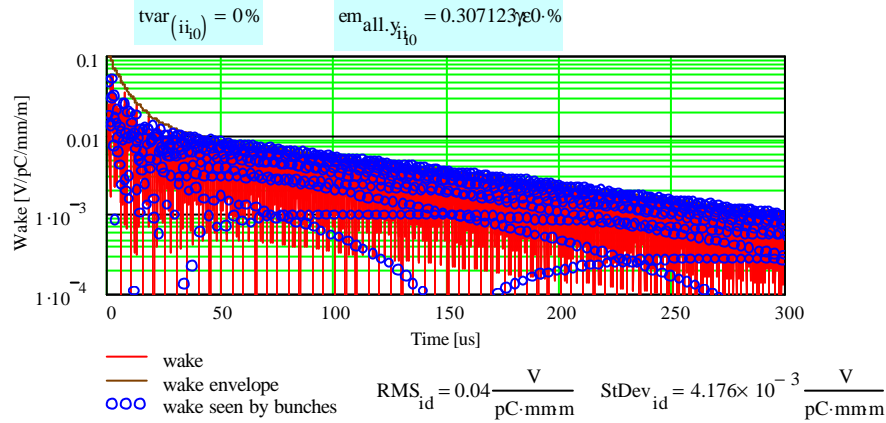
with cav. misal.

$\text{dir}_{(i_{i_0})} = \text{"dtScan\_noRmsDetun(C1-F0.0001-t-13600)"}$

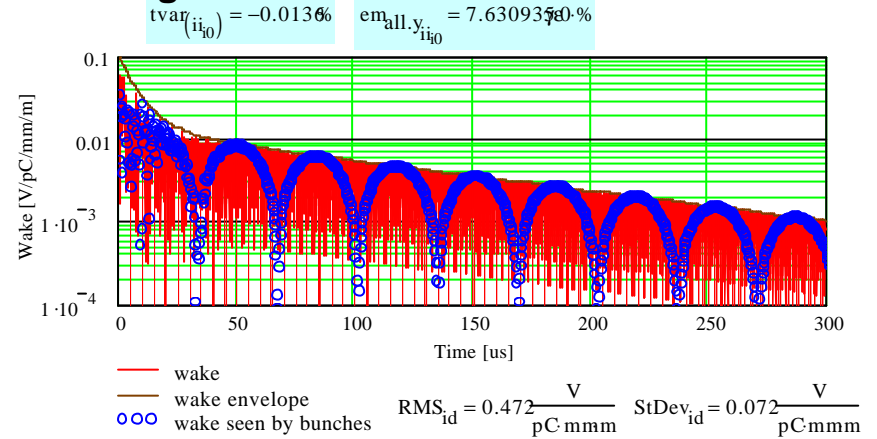


# Wake Field and Sum Wake

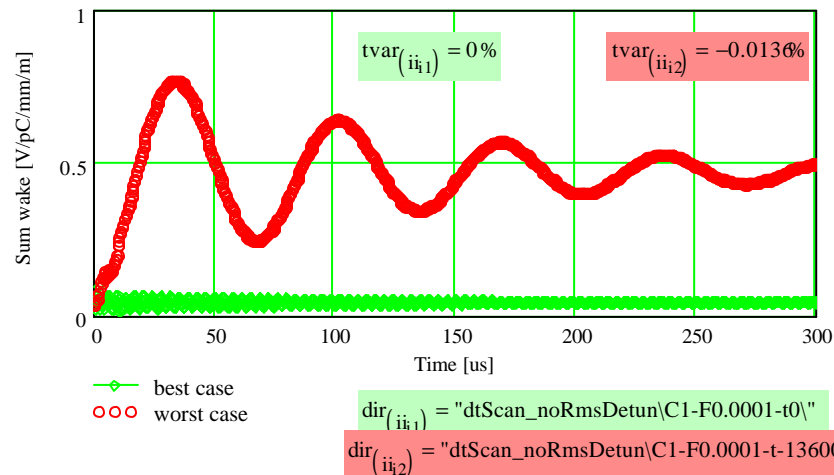
dt = 0



max emit growth



## Sum wake



# Detuning

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- **Random detuning**

- from fabrication tolerances
- TDR: 0.1%

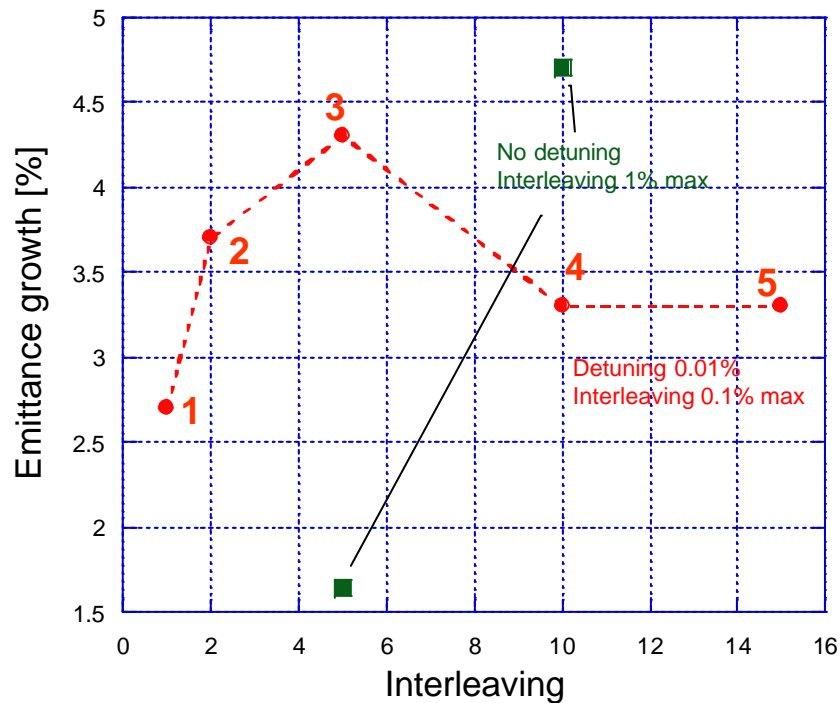
- **Interleaving**

- n-fold interleaving =
  - $n_{cl} = 1 \dots 15$
- $df_{shift}$  = maximum detuning range
  - $df_{shift} = 0.1 \dots 1\%$
  - In first 3 TTF modules
    - 0.5 .. 0.6% for 1<sup>st</sup> band
    - 0.05 .. 0.2% for 2<sup>nd</sup>
- all modes shift with same percentage  $df$  ( $i=0..n-1$ )

$$f_{i,m} = f_{0,m} \cdot \left( 1 + i \frac{df_{shift}}{n-1} \right)$$

# Emittance with Detuning and Interleaving

- Design bunch spacing



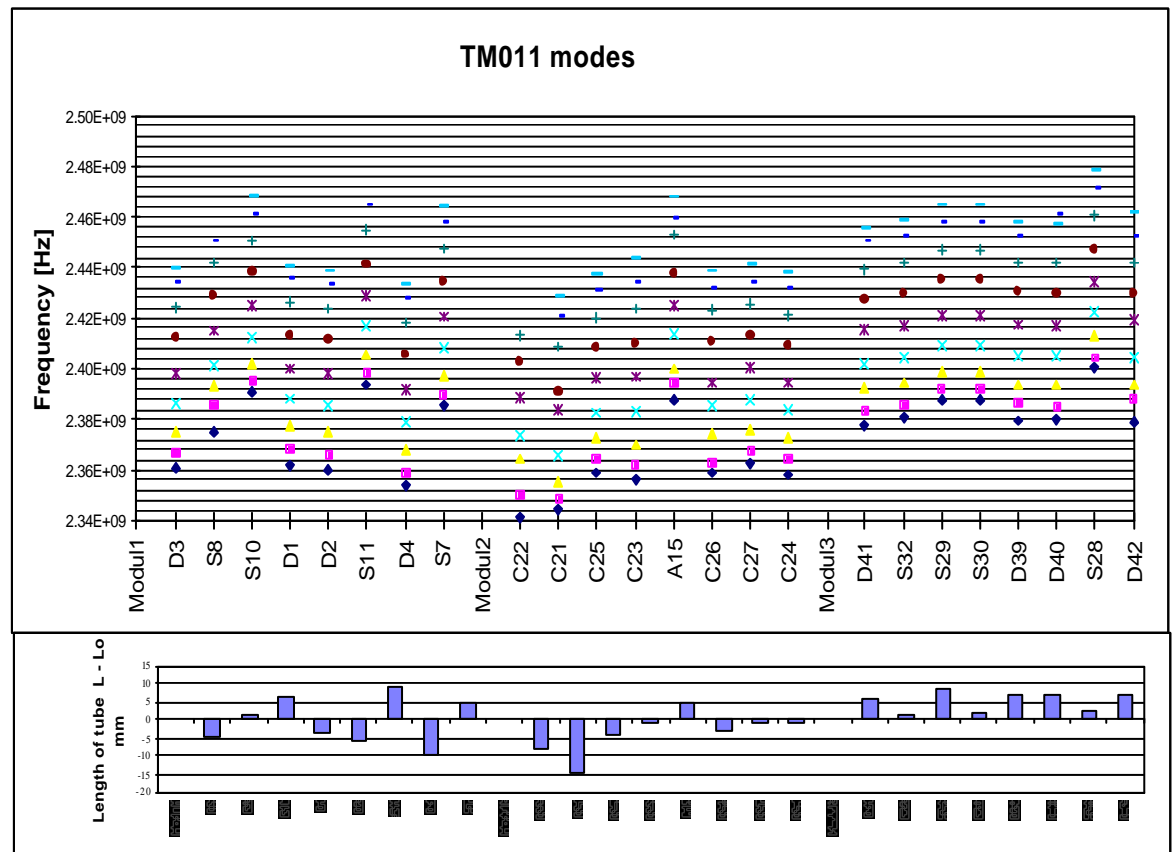
| Misalign. (500 mm rms) | Random detun. | Interl. (max) | Emit. growth [%] |
|------------------------|---------------|---------------|------------------|
| - (#)                  | -             | -             | 0.3              |
| X                      | -             | -             | 24               |
| - (#)                  | -             | 5 / 1%        | 0.006            |
| X                      | -             | 5 / 1%        | 1.64             |
| X                      | -             | 10 / 1%       | 4.7              |
| X                      | 0.1%          | -             | 3.7              |
| X(1)                   | 0.01%         | -             | 2.7              |
| X(2)                   | 0.01%         | 2 / 0.1%      | 3.7              |
| X(3)                   | 0.01%         | 5 / 0.1%      | 4.3              |
| X(4)                   | 0.01%         | 10 / 0.1%     | 3.3              |
| X(5)                   | 0.01%         | 15 / 0.1%     | 3.3              |

# - injection offset 4 mm

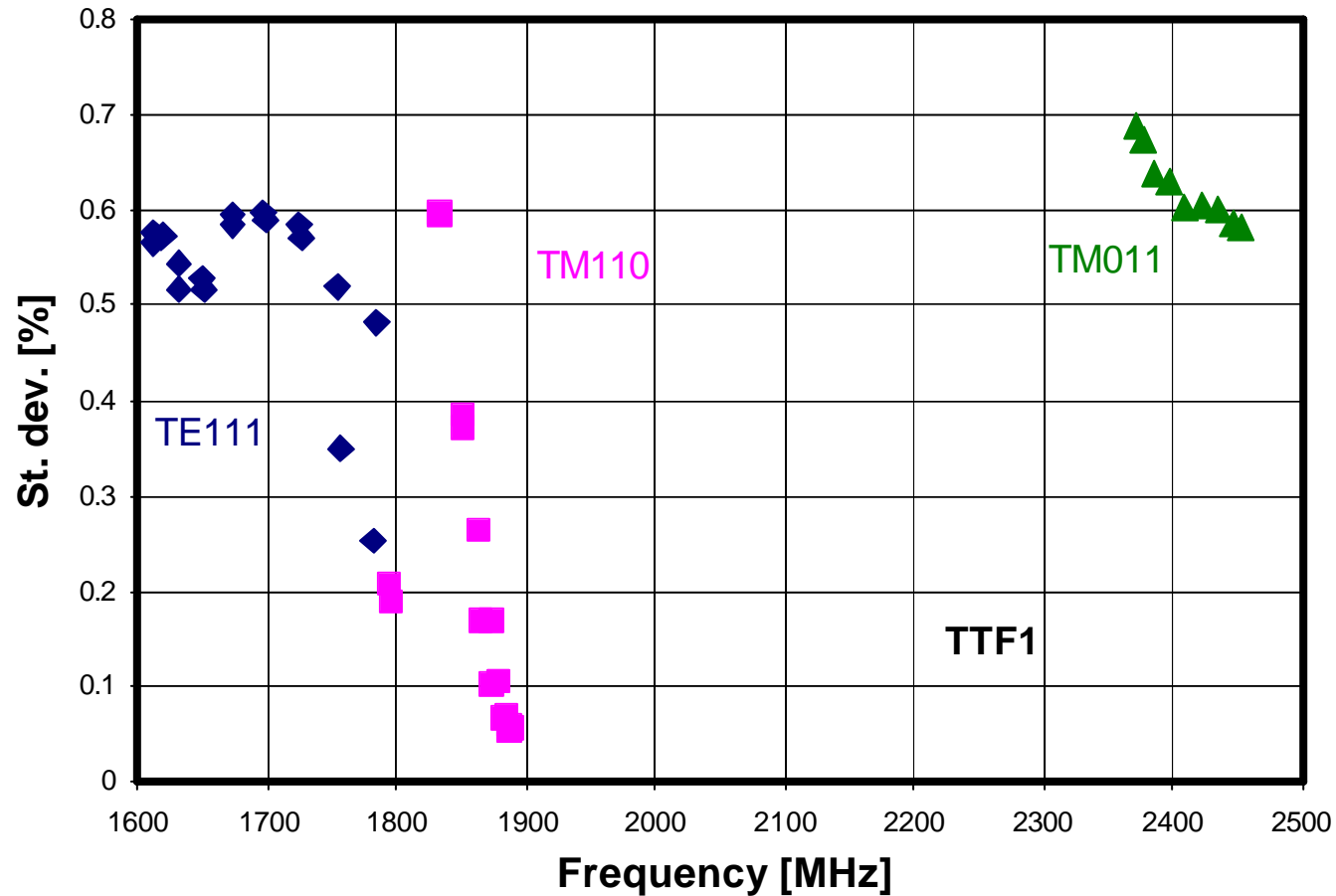
X - 500 mm random misalignments (no injection offset)

# Geometrical Spread in TTF1 Cavities

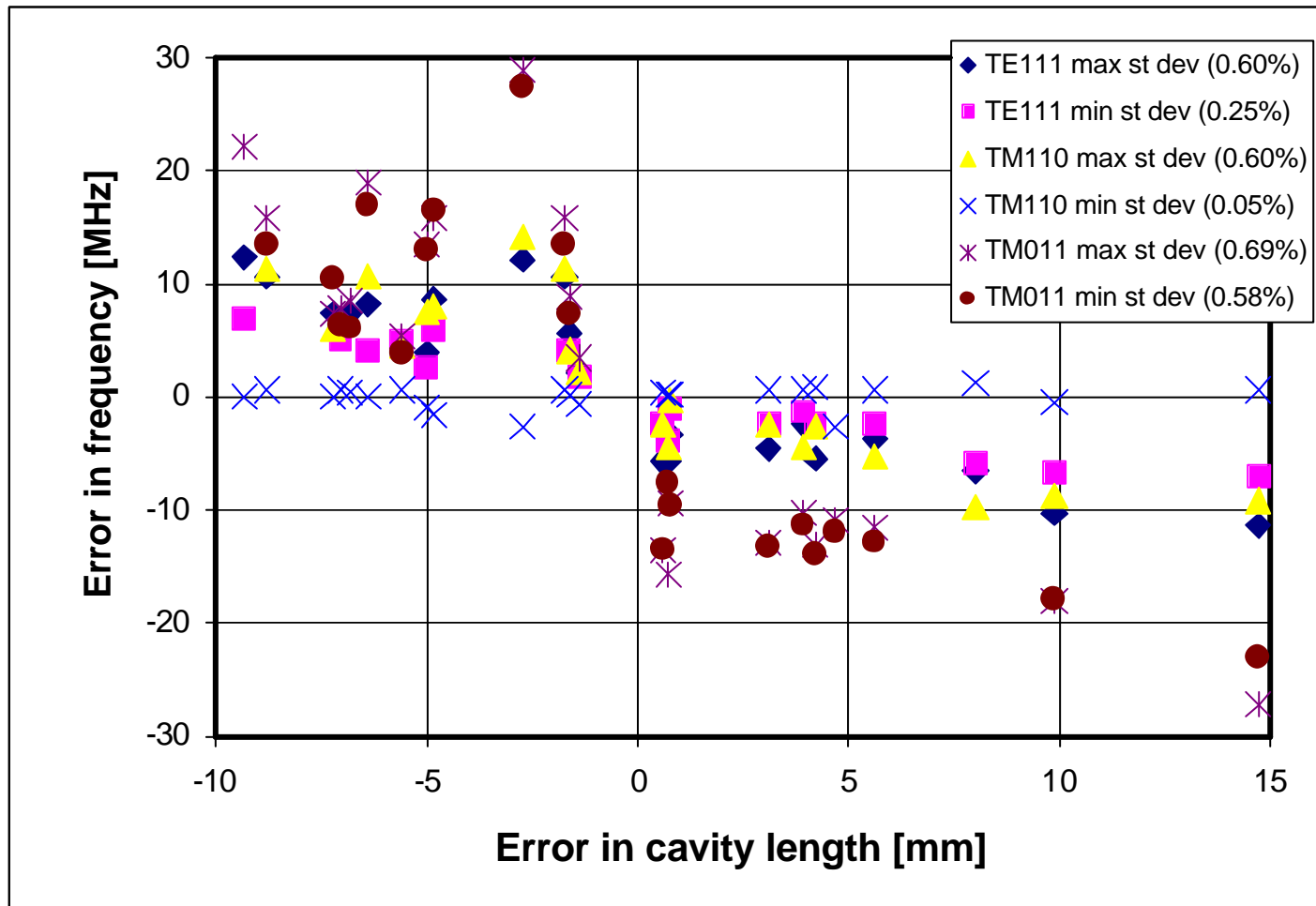
- 24 cavities
- St. dev. of cavity length:  
6.3 mm  $\rightarrow$  0.6%
- St. dev. of frequency of first monopole mode  
16 MHz  $\rightarrow$  0.7%



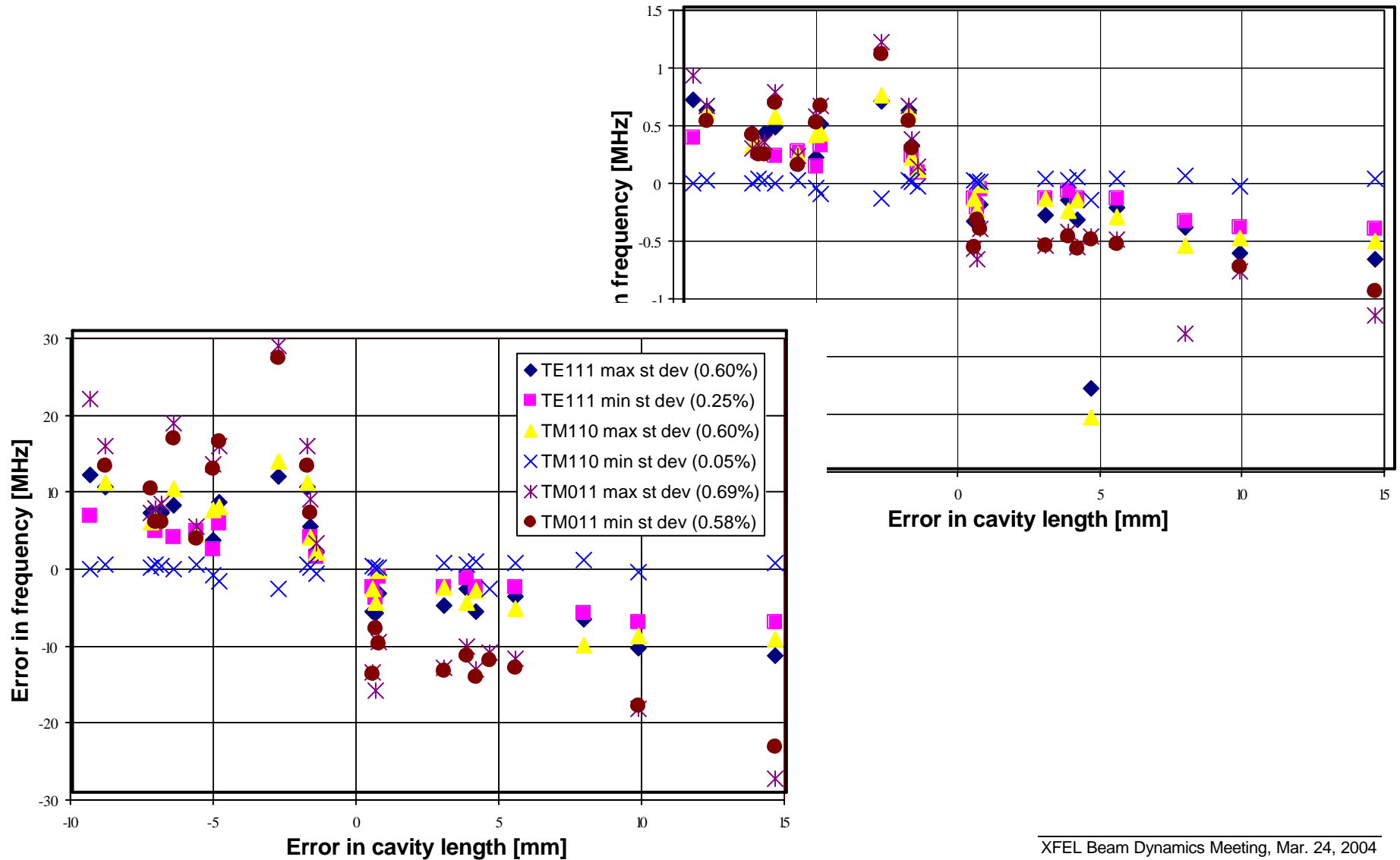
# Frequency Errors in TTF1 Cavities



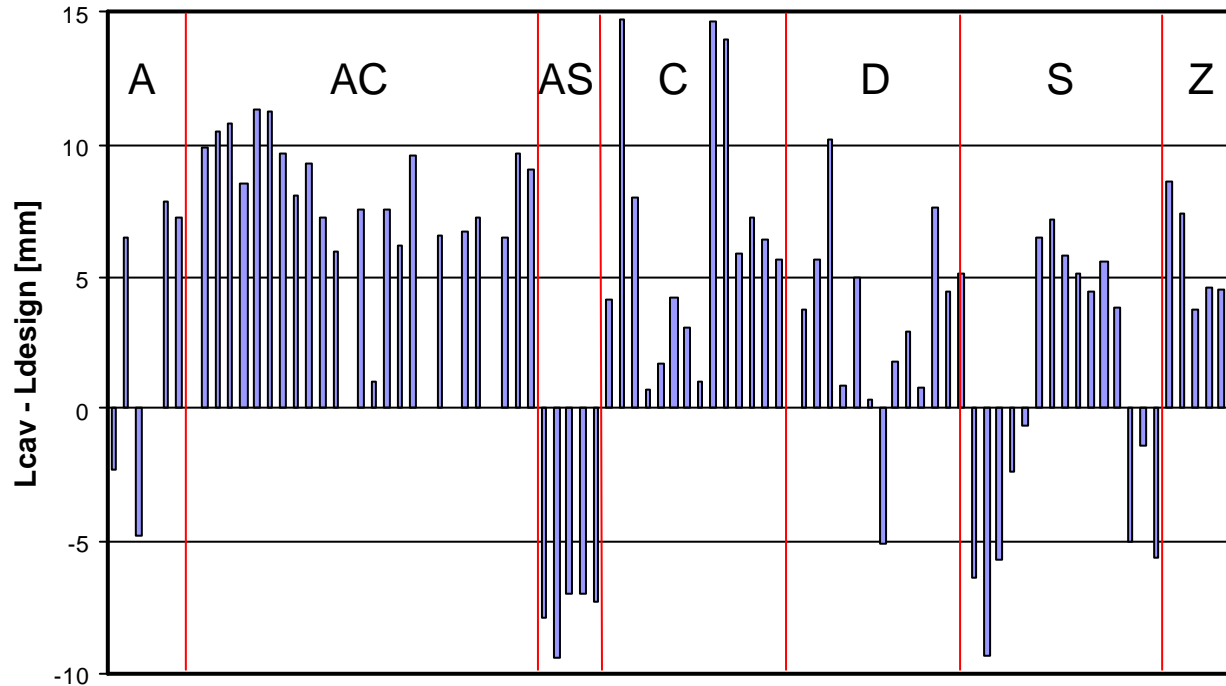
# Correlation between Frequency and Length Errors (TTF1)



# Correlation between Frequency and Length Errors (TTF1)



# Length of TTF Cavities



- Cavity length:

- average: +4.16 mm
- st. dev.: 5.74 mm (0.45%)

# Length of TTF Cavities by Series

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| Series    | # cav | Ave     | Ave_diff | Stdev | Stdev | fabricated between |           |
|-----------|-------|---------|----------|-------|-------|--------------------|-----------|
|           |       | [mm]    | [mm]     | [mm]  | [%]   |                    |           |
| <b>C</b>  | 14    | 1282.72 | 6.52     | 4.82  | 0.38  | 07-Mar-95          | 19-Jan-04 |
| <b>D</b>  | 12    | 1279.37 | 3.17     | 3.93  | 0.31  | 24-Aug-95          | 19-Sep-03 |
| <b>S</b>  | 15    | 1276.32 | 0.12     | 5.61  | 0.44  | 30-Jul-96          | 22-Apr-02 |
| <b>AS</b> | 5     | 1268.48 | -7.72    | 1.01  | 0.08  | 24-Apr-97          | 14-Dec-01 |
| <b>A</b>  | 6     | 1279.07 | 2.87     | 5.95  | 0.46  | 19-Mar-98          | 01-Jul-03 |
| <b>AC</b> | 27    | 1284.38 | 8.18     | 2.32  | 0.18  | 06-Jul-00          | 05-Mar-04 |
| <b>Z</b>  | 6     | 1281.91 | 5.71     | 1.87  | 0.15  | 07-Aug-00          | 19-Mar-03 |

# Outlook

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- Study various options:
  - interleaving:
    - 2-fold up to 10-fold
    - various frequency range
  - random detuning
    - various detuning range
- For each case study tolerances on fabrication
- Use information from newest TTF cavities